



# DRAM

## MT4LC8M8P4, MT4LC8M8C2

For the latest data sheet, please refer to the Micron Web site: [www.micronsemi.com/mti/msp/html/datasheet.html](http://www.micronsemi.com/mti/msp/html/datasheet.html)

### FEATURES

- Single +3.3V ±0.3V power supply
- Industry-standard x8 pinout, timing, functions, and packages
- 12 row, 11 column addresses (C2) or 13 row, 10 column addresses (P4)
- High-performance CMOS silicon-gate process
- All inputs, outputs and clocks are LVTTL-compatible
- Extended Data-Out (EDO) PAGE MODE access
- 4,096-cycle CAS#-BEFORE-RAS# (CBR) REFRESH distributed across 64ms
- Optional self refresh (S) for low-power data retention

### OPTIONS

- Refresh Addressing

4,096 (4K) rows  
8,192 (8K) rows

### MARKING

C2  
P4

- Plastic Packages

32-pin SOJ (400 mil)  
32-pin TSOP (400 mil)

DJ  
TG

- Timing

50ns access  
60ns access

-5  
-6

- Refresh Rates

Standard Refresh (64ms period)  
Self Refresh (128ms period)

None  
S\*

**NOTE:** 1. The 8 Meg x 8 EDO DRAM base number differentiates the offerings in one place—MT4LC8M8C2. The fifth field distinguishes the address offerings: C2 designates 4K addresses and P4 designates 8K addresses.

2. The “#” symbol indicates signal is active LOW.

\*Contact factory for availability

Part Number Example:

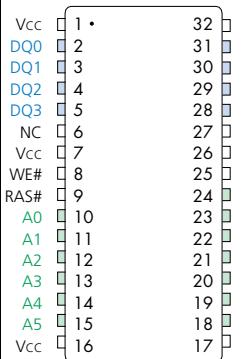
**MT4LC8M8C2DJ-5**

### KEY TIMING PARAMETERS

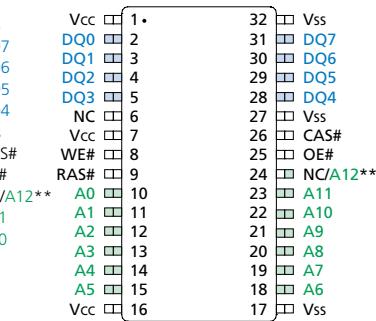
SPEED	t <sub>RC</sub>	t <sub>RAC</sub>	t <sub>PC</sub>	t <sub>AA</sub>	t <sub>CAC</sub>	t <sub>CAS</sub>
-5	84ns	50ns	20ns	25ns	13ns	8ns
-6	104ns	60ns	25ns	30ns	15ns	10ns

### PIN ASSIGNMENT (Top View)

#### 32-Pin SOJ



#### 32-Pin TSOP



\*\*NC on C2 version and A12 on P4 version

### 8 MEG x 8 EDO DRAM PART NUMBERS

PART NUMBER	REFRESH ADDRESSING	PACKAGE	REFRESH
MT4LC8M8C2DJ-x	4K	SOJ	Standard
MT4LC8M8C2DJ-x S	4K	SOJ	Self
MT4LC8M8C2TG-x	4K	TSOP	Standard
MT4LC8M8C2TG-x S	4K	TSOP	Self
MT4LC8M8P4DJ-x	8K	SOJ	Standard
MT4LC8M8P4DJ-x S	8K	SOJ	Self
MT4LC8M8P4TG-x	8K	TSOP	Standard
MT4LC8M8P4TG-x S	8K	TSOP	Self

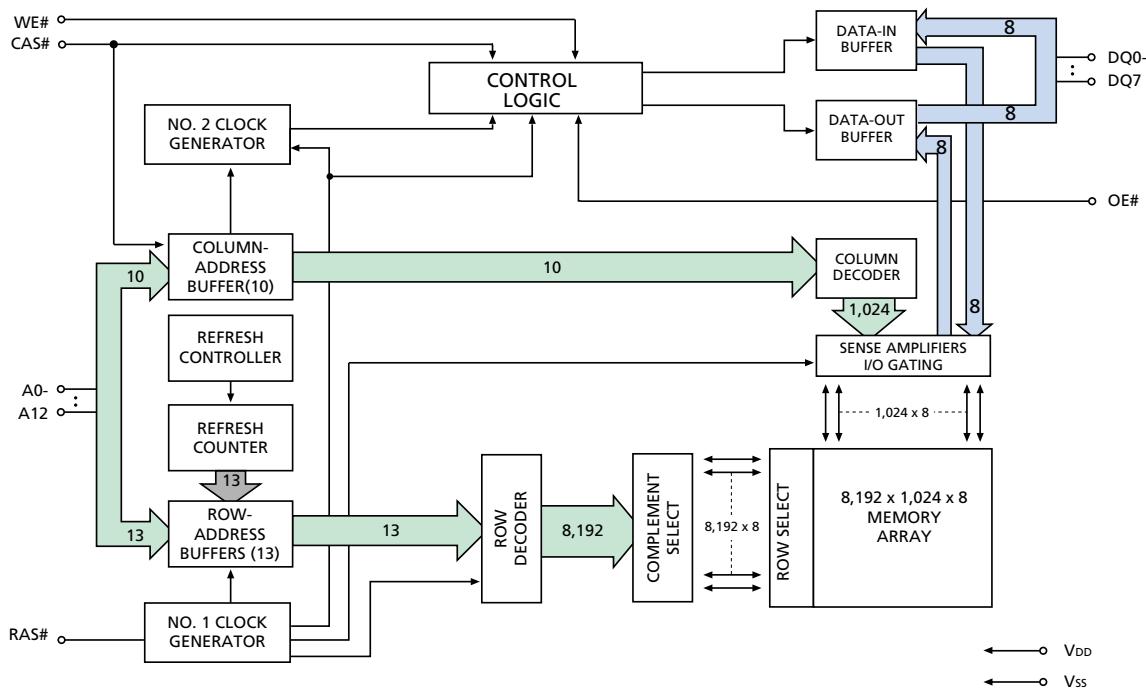
x = speed

### GENERAL DESCRIPTION

The 8 Meg x 8 DRAM is a high-speed CMOS, dynamic random-access memory devices containing 67,108,864 bits and designed to operate from 3V to 3.6V. The MT4LC8M8C2 and MT4LC8M8P4 are functionally organized as 8,388,608 locations containing eight bits each. The 8,388,608 memory locations are arranged in 4,096 rows by 2,048 columns on the C2 version and 8,192 rows by 1,024 columns on the P4 version. During READ or WRITE cycles, each location is

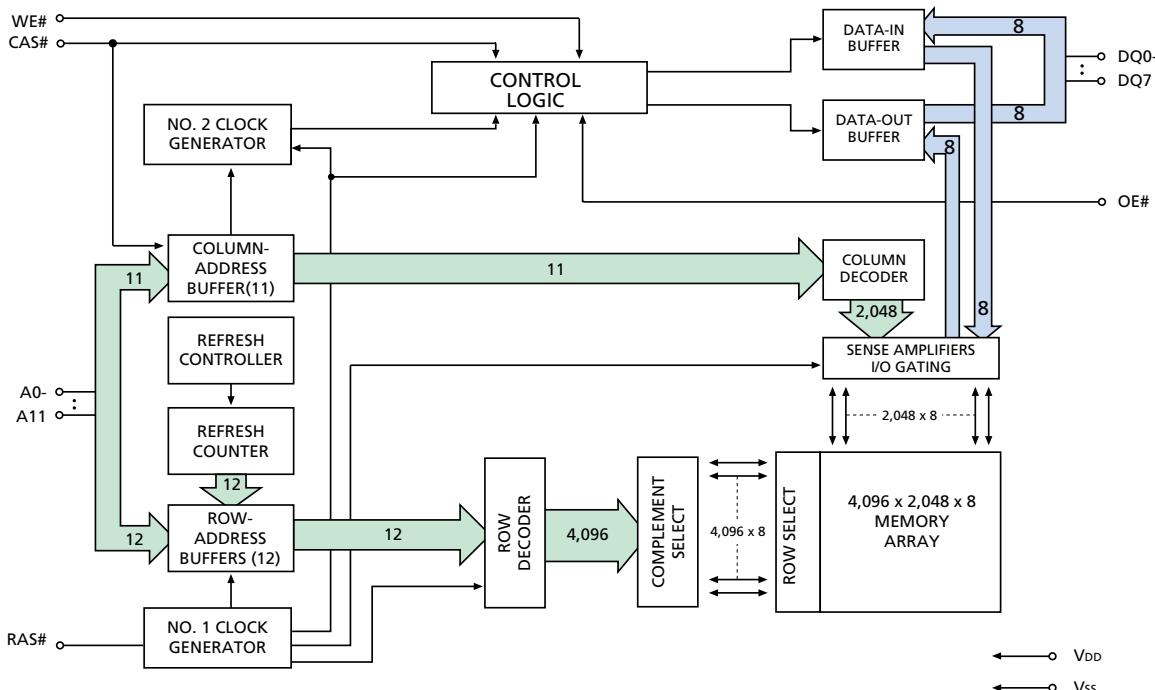
## FUNCTIONAL BLOCK DIAGRAM

MT4LC8M8P4 (13 row addresses)



## FUNCTIONAL BLOCK DIAGRAM

MT4LC8M8C2 (12 row addresses)





## GENERAL DESCRIPTION (continued)

uniquely addressed via the address bits. First, the row address is latched by the RAS# signal, then the column address is latched by CAS#. Both devices provide EDO-PAGE-MODE operation, allowing for fast successive data operations (READ, WRITE, or READ-MODIFY-WRITE) within a given row.

The 8 Meg x 8 DRAM must be refreshed periodically in order to retain stored data.

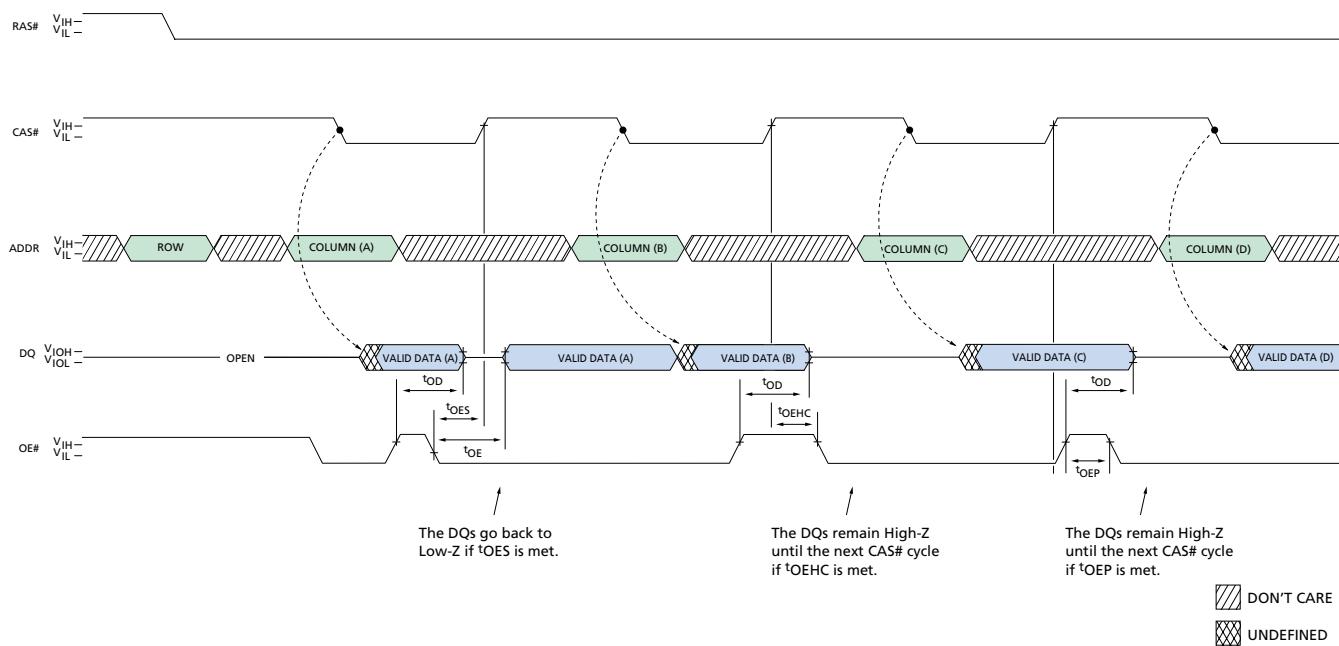
## DRAM ACCESS

Each location in the DRAM is uniquely addressable, as mentioned in the General Description. The data for each location is accessed via the eight I/O pins (DQ0-DQ7). A logic HIGH on WE# dictates read mode, while a logic LOW on WE# dictates write mode. During a WRITE cycle, data-in (D) is latched by the falling edge of WE# or CAS#, whichever occurs last. An EARLY WRITE occurs when WE# is taken LOW prior to CAS# falling. A LATE WRITE or READ-MODIFY-WRITE occurs when WE# falls after CAS# is taken LOW. During EARLY WRITE cycles, the data outputs (Q) will remain High-Z, regardless of the state of OE#. During LATE WRITE or READ-MODIFY-WRITE cycles, OE# must be taken HIGH to disable the data outputs prior to applying input data. If a LATE WRITE or READ-MODIFY-WRITE is attempted while keeping OE# LOW, no write will occur, and the data outputs will drive read data from the accessed location.

## EDO PAGE MODE

DRAM READ cycles have traditionally turned the output buffers off (High-Z) with the rising edge of CAS#. If CAS# went HIGH and OE# was LOW (active), the output buffers would be disabled. The 8 Meg x 8 DRAM offers an accelerated page mode cycle by eliminating output disable from CAS# HIGH. This option is called EDO, and it allows CAS# precharge time ( $t_{CP}$ ) to occur without the output data going invalid (see READ and EDO-PAGE-MODE READ waveforms in the noted appendix).

EDO operates like any DRAM READ or FAST-PAGE-MODE READ, except data is held valid after CAS# goes HIGH, as long as RAS# and OE# are held LOW and WE# is held HIGH. OE# can be brought LOW or HIGH while CAS# and RAS# are LOW, and the DQs will transition between valid data and High-Z. Using OE#, there are two methods to disable the outputs and keep them disabled during the CAS# HIGH time. The first method is to have OE# HIGH when CAS# transitions HIGH and keep OE# HIGH for  $t_{OEHC}$  thereafter. This will disable the DQs, and they will remain disabled (regardless of the state of OE# after that point) until CAS# falls again. The second method is to have OE# LOW when CAS# transitions HIGH and then bring OE# HIGH for a minimum of  $t_{OEP}$  anytime during the CAS# HIGH period. This will disable the DQs, and they will remain disabled (regardless of the state of OE# after that point) until CAS# falls again (see Figure 1). During



**Figure 1**  
**OE# CONTROL of DQs**



## EDO PAGE MODE (continued)

other cycles, the outputs are disabled at  $t_{OFF}$  time after RAS# and CAS# are HIGH or at  $t_{WHZ}$  after WE# transitions LOW. The  $t_{OFF}$  time is referenced from the rising edge of RAS# or CAS#, whichever occurs last. WE# can also perform the function of disabling the output drivers under certain conditions, as shown in Figure 2.

EDO-PAGE-MODE operations are always initiated with a row address strobed in by the RAS# signal, followed by a column address strobed in by CAS#, just like for single location accesses. However, subsequent column locations within the row may then be accessed at the page mode cycle time. This is accomplished by cycling CAS# while holding RAS# LOW and entering new column addresses with each CAS# cycle. Returning RAS# HIGH terminates the EDO-PAGE-MODE operation.

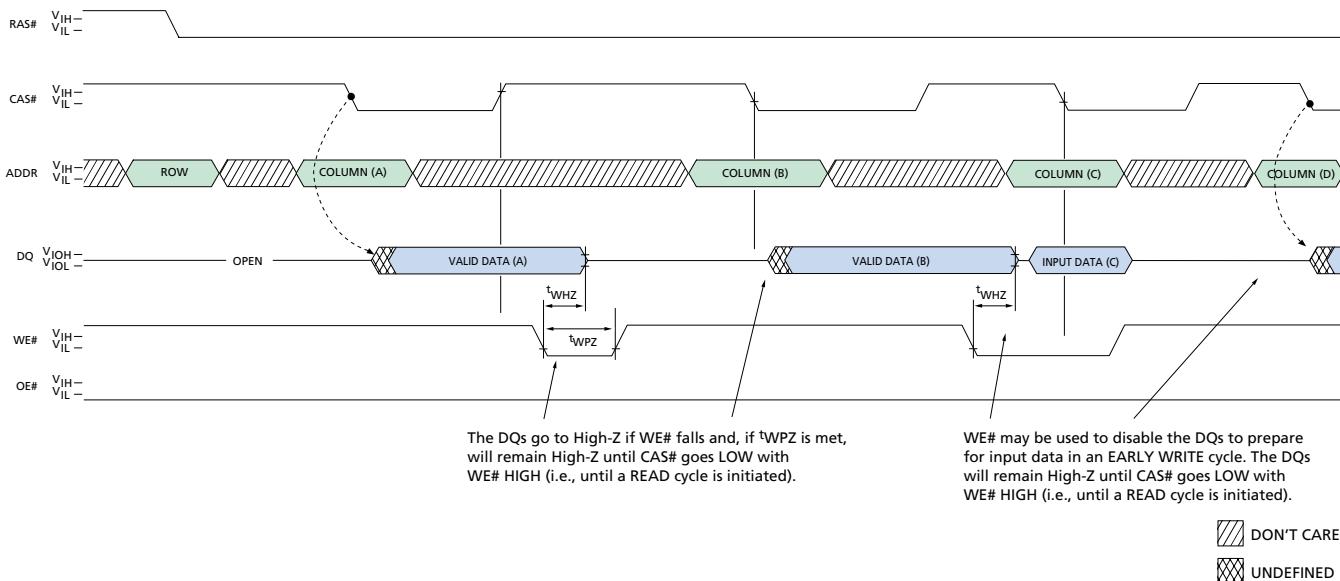
## DRAM REFRESH

The supply voltage must be maintained at the specified levels, and the refresh requirements must be met in order to retain stored data in the DRAM. The refresh requirements are met by refreshing all 8,192 rows (P4) or all 4,096 rows (C2) in the DRAM array at least once every 64ms. The recommended procedure is to execute 4,096 CBR REFRESH cycles, either uniformly spaced or grouped in bursts, every 64ms. The MT4LC8M8P4 internally refreshes two rows for every CBR cycle, whereas the MT4LC8M8C2 refreshes one row for every CBR cycle. So with either device, executing 4,096 CBR cycles

covers all rows. The CBR REFRESH cycle will invoke the internal refresh counter for automatic RAS# addressing. Alternatively, RAS#-ONLY REFRESH capability is inherently provided. However, with this method, some compatibility issues may become apparent. For example, both C2 and P4 versions require 4,096 CBR REFRESH cycles, yet each requires a different number of RAS#-ONLY REFRESH cycles (C2 = 4,096 and P4 = 8,192). JEDEC strongly recommends the use of CBR REFRESH for this device.

An optional self refresh mode is also available on the "S" version. The self refresh feature is initiated by performing a CBR REFRESH cycle and holding RAS# LOW for the specified  $t_{RASS}$ . The "S" option allows for an extended period of 128ms, or 31.25 $\mu$ s per row for a 4K refresh and 15.625 $\mu$ s per row for an 8K refresh, when using a distributed CBR REFRESH. This refresh rate can be applied during normal operation, as well as during a standby or battery backup mode.

The self refresh mode is terminated by driving RAS# HIGH for a minimum time of  $t_{RPS}$ . This delay allows for the completion of any internal refresh cycles that may be in process at the time of the RAS# LOW-to-HIGH transition. If the DRAM controller uses a distributed CBR refresh sequence, a burst refresh is not required upon exiting self refresh. However, if the DRAM controller utilizes a RAS#-ONLY or burst CBR refresh sequence, all 1,024 rows must be refreshed using a minimum  $t_{RC}$  refresh rate prior to resuming normal operation.



**Figure 2**  
**WE# CONTROL of DQs**

**ABSOLUTE MAXIMUM RATINGS\***

Voltage on Vcc Relative to Vss .....	-1V to +4.6V
Voltage on NC, Inputs or I/O Pins	
Relative to Vss .....	-1V to +4.6V
Operating Temperature, $T_A$ (ambient) ...	0°C to +70°C
Storage Temperature (plastic) .....	-55°C to +150°C
Power Dissipation .....	1W

\*Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

**DC ELECTRICAL CHARACTERISTICS AND OPERATING CONDITIONS**(Note: 1) ( $V_{CC} = +3.3V \pm 0.3V$ )

PARAMETER/CONDITION	SYMBOL	MIN	MAX	UNITS	NOTES
SUPPLY VOLTAGE	$V_{CC}$	3	3.6	V	
INPUT HIGH VOLTAGE: Valid Logic 1; All inputs, I/Os and any NC	$V_{IH}$	2	$V_{CC} + 0.3$	V	26
INPUT LOW VOLTAGE: Valid Logic 0; All inputs, I/Os and any NC	$V_{IL}$	-0.3	0.8	V	26
INPUT LEAKAGE CURRENT: Any input at $V_{IN}$ ( $0V \leq V_{IN} \leq V_{CC} + 0.3V$ ); All other pins not under test = $0V$	$I_{II}$	-2	2	$\mu A$	27
OUTPUT HIGH VOLTAGE: $I_{OUT} = -2mA$	$V_{OH}$	2.4	-	V	
OUTPUT LOW VOLTAGE: $I_{OUT} = 2mA$	$V_{OL}$	-	0.4	V	
OUTPUT LEAKAGE CURRENT: Any output at $V_{OUT}$ ( $0V \leq V_{OUT} \leq V_{CC} + 0.3V$ ); DQ is disabled and in High-Z state	$I_{OZ}$	-5	5	$\mu A$	

**I<sub>cc</sub> OPERATING CONDITIONS AND MAXIMUM LIMITS**(Notes: 1, 2, 3, 5, 6) (V<sub>CC</sub> = +3.3V ±0.3V)

PARAMETER/CONDITION	SYMBOL	SPEED	4K REFRESH	8K REFRESH	UNITS	NOTES
STANDBY CURRENT: TTL (RAS# = CAS# = V <sub>IH</sub> )	I <sub>CC1</sub>	ALL	1	1	mA	
STANDBY CURRENT: CMOS (RAS# = CAS# ≥ V <sub>CC</sub> - 0.2V; DQs may be left open; other inputs: V <sub>IN</sub> ≥ V <sub>CC</sub> - 0.2V or V <sub>IN</sub> ≤ 0.2V)	I <sub>CC2</sub>	ALL	500	500	µA	
OPERATING CURRENT: Random READ/WRITE Average power supply current (RAS#, CAS#, address cycling: t <sub>RC</sub> = t <sub>RC</sub> [MIN])	I <sub>CC3</sub>	-5 -6	175 165	135 125	mA	25
OPERATING CURRENT: EDO PAGE MODE Average power supply current (RAS# = V <sub>IL</sub> , CAS#, address cycling: t <sub>PC</sub> = t <sub>PC</sub> [MIN])	I <sub>CC4</sub>	-5 -6	155 125	155 125	mA	25
REFRESH CURRENT: RAS#-ONLY Average power supply current (RAS# cycling, CAS# = V <sub>IH</sub> : t <sub>RC</sub> = t <sub>RC</sub> [MIN])	I <sub>CC5</sub>	-5 -6	175 165	135 125	mA	22
REFRESH CURRENT: CBR Average power supply current (RAS#, CAS#, address cycling: t <sub>RC</sub> = t <sub>RC</sub> [MIN])	I <sub>CC6</sub>	-5 -6	165 155	165 155	mA	4, 7
REFRESH CURRENT: Extended ("S" version only) Average power supply current: CAS# = 0.2V or CBR cycling; RAS# = t <sub>RAS</sub> (MIN); WE# = V <sub>CC</sub> - 0.2V; A0-A11, OE# and DIN = V <sub>CC</sub> - 0.2V or 0.2V (DIN may be left open)	I <sub>CC7</sub>	ALL	400	400	µA	4, 7
REFRESH CURRENT: Self ("S" version only) Average power supply current: CBR with RAS# ≥ t <sub>RASS</sub> (MIN) and CAS# held LOW; WE# = V <sub>CC</sub> - 0.2V; A0-A11, OE# and DIN = V <sub>CC</sub> - 0.2V or 0.2V (DIN may be left open)	I <sub>CC8</sub>	ALL	350	400	µA	4, 7

**CAPACITANCE**

(Note: 2)

PARAMETER	SYMBOL	MAX	UNITS
Input Capacitance: Address pins	C <sub>I1</sub>	5	pF
Input Capacitance: RAS#, CAS#, WE#, OE#	C <sub>I2</sub>	7	pF
Input/Output Capacitance: DQ	C <sub>Io</sub>	7	pF

**AC ELECTRICAL CHARACTERISTICS**(Notes: 5, 6, 7, 8, 9, 10, 11, 12) (V<sub>CC</sub> = +3.3V ±0.3V)

AC CHARACTERISTICS	PARAMETER	SYMBOL	-5		-6		NOTES
			MIN	MAX	MIN	MAX	
Access time from column address	t <sub>AA</sub>			25		30	ns
Column-address setup to CAS# precharge	t <sub>ACH</sub>		12		15		ns
Column-address hold time (referenced to RAS#)	t <sub>AR</sub>		38		45		ns
Column-address setup time	t <sub>ASC</sub>		0		0		ns
Row-address setup time	t <sub>ASR</sub>		0		0		ns
Column address to WE# delay time	t <sub>AWD</sub>		42		49		ns 18
Access time from CAS#	t <sub>CAC</sub>			13		15	ns
Column-address hold time	t <sub>CAH</sub>		8		10		ns
CAS# pulse width	t <sub>CAS</sub>		8	10,000	10	10,000	ns
CAS# LOW to "Don't Care" during Self Refresh	t <sub>CHD</sub>		15		15		ns
CAS# hold time (CBR Refresh)	t <sub>CHR</sub>		8		10		ns 4
CAS# to output in Low-Z	t <sub>CLZ</sub>		0		0		ns
Data output hold after CAS# LOW	t <sub>COH</sub>		3		3		ns
CAS# precharge time	t <sub>CP</sub>		8		10		ns 13
Access time from CAS# precharge	t <sub>CPA</sub>			28		35	ns
CAS# to RAS# precharge time	t <sub>CRP</sub>		5		5		ns
CAS# hold time	t <sub>CSH</sub>		38		45		ns
CAS# setup time (CBR Refresh)	t <sub>CSR</sub>		5		5		ns 4
CAS# to WE# delay time	t <sub>CWD</sub>		28		35		ns 18
Write command to CAS# lead time	t <sub>CWL</sub>		8		10		ns
Data-in hold time	t <sub>DH</sub>		8		10		ns 19
Data-in setup time	t <sub>DS</sub>		0		0		ns 19
Output disable	t <sub>OD</sub>		0	12	0	15	ns 23, 24
Output enable time	t <sub>OE</sub>			12		15	ns 20
OE# hold time from WE# during READ-MODIFY-WRITE cycle	t <sub>OEH</sub>		8		10		ns 24
OE# HIGH hold time from CAS# HIGH	t <sub>OEHC</sub>		5		10		ns
OE# HIGH pulse width	t <sub>OEP</sub>		5		5		ns
OE# LOW to CAS# HIGH setup time	t <sub>OES</sub>		4		5		ns
Output buffer turn-off delay	t <sub>OFF</sub>		0	12	0	15	ns 17, 23



## AC ELECTRICAL CHARACTERISTICS

(Notes: 5, 6, 7, 8, 9, 10, 11, 12) ( $V_{CC} = +3.3V \pm 0.3V$ )

AC CHARACTERISTICS	PARAMETER	SYMBOL	-5		-6		UNITS	NOTES
			MIN	MAX	MIN	MAX		
OE# setup prior to RAS# during HIDDEN REFRESH cycle	$t_{ORD}$		0		0		ns	
EDO-PAGE-MODE READ or WRITE cycle time	$t_{PC}$		20		25		ns	
EDO-PAGE-MODE READ-WRITE cycle time	$t_{PRWC}$		47		56		ns	
Access time from RAS#	$t_{RAC}$			50		60	ns	
RAS# to column-address delay time	$t_{RAD}$		9		12		ns	15
Row-address hold time	$t_{RAH}$		9		10		ns	
RAS# pulse width	$t_{RAS}$		50	10,000	60	10,000	ns	
RAS# pulse width (EDO PAGE MODE)	$t_{RASP}$		50	125,000	60	125,000	ns	
RAS# pulse width during Self Refresh	$t_{RASS}$		100		100		$\mu s$	
Random READ or WRITE cycle time	$t_{RC}$		84		104		ns	
RAS# to CAS# delay time	$t_{RCD}$		11		14		ns	14
READ command hold time (referenced to CAS#)	$t_{RCH}$		0		0		ns	16
READ command setup time	$t_{RCS}$		0		0		ns	
Refresh period	$t_{REF}$			64		64	ms	23
Refresh period (2,048 cycles) "S" version	$t_{REF}$			128		128	ms	
RAS# precharge time	$t_{RP}$		30		40		ns	
RAS# to CAS# precharge time	$t_{RPC}$		5		5		ns	
RAS# precharge time exiting Self Refresh	$t_{RPS}$		90		105		ns	
READ command hold time (referenced to RAS#)	$t_{RRH}$		0		0		ns	16
RAS# hold time	$t_{RSH}$		13		15		ns	
READ-WRITE cycle time	$t_{RWC}$		116		140		ns	
RAS# to WE# delay time	$t_{RWD}$		67		79		ns	18
WRITE command to RAS# lead time	$t_{RWL}$		13		15		ns	
Transition time (rise or fall)	$t_T$		2	50	2	50	ns	
WRITE command hold time	$t_{WCH}$		8		10		ns	
WRITE command hold time (referenced to RAS#)	$t_{WCR}$		38		45		ns	
WE# command setup time	$t_{WCS}$		0		0		ns	18
WE# to outputs in High-Z	$t_{WHZ}$			12		15	ns	
WRITE command pulse width	$t_{WP}$		5		5		ns	
WE# pulse widths to disable outputs	$t_{WPZ}$		10		10		ns	
WE# hold time (CBR Refresh)	$t_{WRH}$		8		10		ns	
WE# setup time (CBR Refresh)	$t_{WRP}$		8		10		ns	



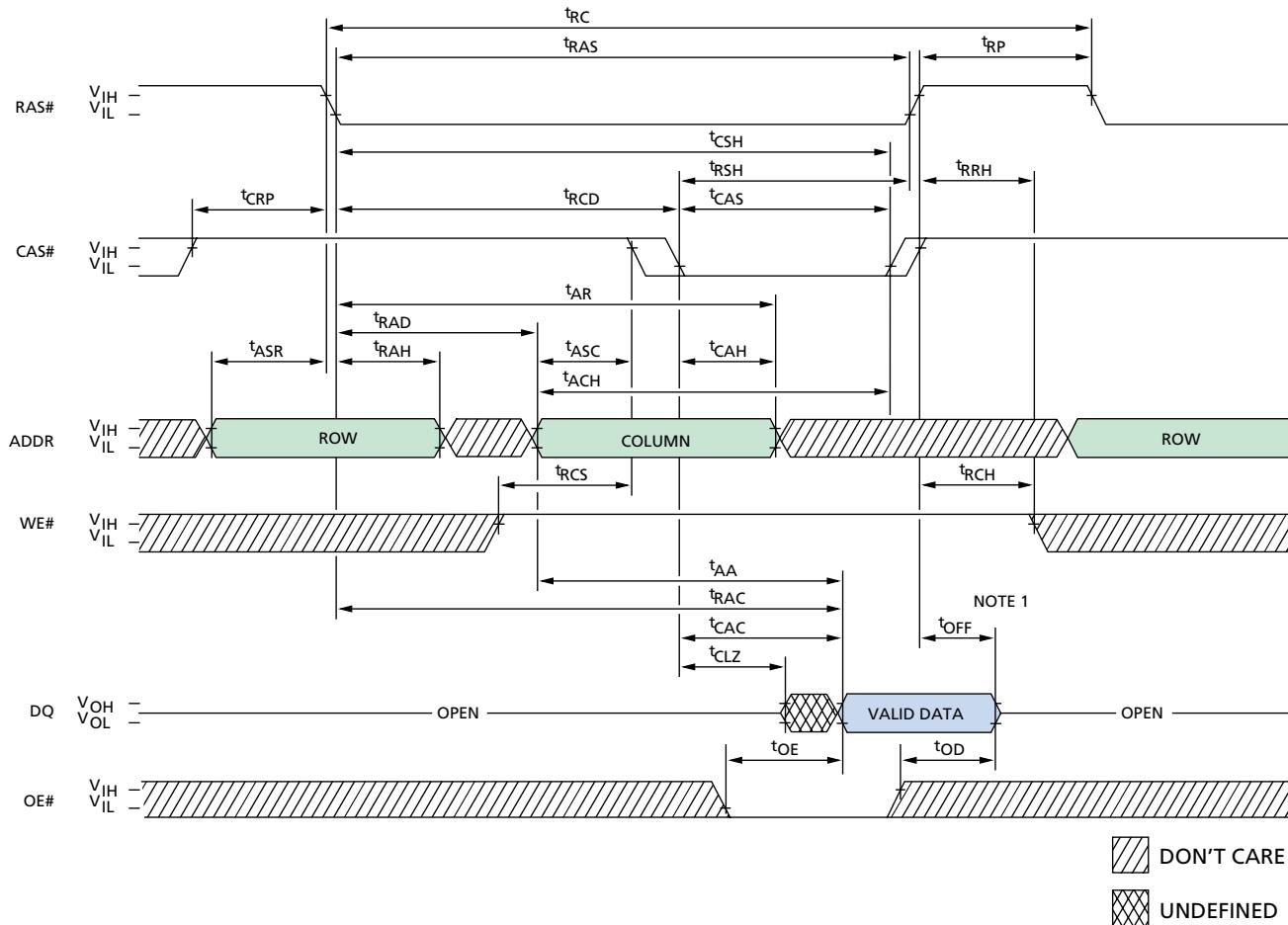
## NOTES

1. All voltages referenced to Vss.
2. This parameter is sampled.  $V_{CC} = +3.3V$ ;  $f = 1$  MHz;  $T_A = 25^\circ C$ .
3.  $I_{CC}$  is dependent on output loading and cycle rates. Specified values are obtained with minimum cycle time and the outputs open.
4. Enables on-chip refresh and address counters.
5. The minimum specifications are used only to indicate cycle time at which proper operation over the full temperature range is ensured.
6. An initial pause of 100 $\mu$ s is required after power-up, followed by eight RAS# refresh cycles (RAS#-ONLY or CBR with WE# HIGH), before proper device operation is ensured. The eight RAS# cycle wake-ups should be repeated any time the  $t_{REF}$  refresh requirement is exceeded.
7. AC characteristics assume  $t_T = 2.5ns$ .
8.  $V_{IH}$  (MIN) and  $V_{IL}$  (MAX) are reference levels for measuring timing of input signals. Transition times are measured between  $V_{IH}$  and  $V_{IL}$  (or between  $V_{IL}$  and  $V_{IH}$ ).
9. In addition to meeting the transition rate specification, all input signals must transit between  $V_{IH}$  and  $V_{IL}$  (or between  $V_{IL}$  and  $V_{IH}$ ) in a monotonic manner.
10. If CAS# and RAS# =  $V_{IH}$ , data output is High-Z.
11. If CAS# =  $V_{IL}$ , data output may contain data from the last valid READ cycle.
12. Measured with a load equivalent to two TTL gates and 100pF; and  $V_{OL} = 0.8V$  and  $V_{OH} = 2V$ .
13. If CAS# is LOW at the falling edge of RAS#, output data will be maintained from the previous cycle. To initiate a new cycle and clear the data-out buffer, CAS# must be pulsed HIGH for  $t_{CP}$ .
14. The  $t_{RAD}$  (MAX) limit is no longer specified.  $t_{RAD}$  (MAX) was specified as a reference point only. If  $t_{RAD}$  was greater than the specified  $t_{RAD}$  (MAX) limit, then access time was controlled exclusively by  $t_{AA}$  ( $t_{RAC}$  and  $t_{CAC}$  no longer applied). With or without the  $t_{RAD}$  (MAX) limit,  $t_{AA}$ ,  $t_{RAC}$ , and  $t_{CAC}$  must always be met.
15. The  $t_{RCD}$  (MAX) limit is no longer specified.  $t_{RCD}$  (MAX) was specified as a reference point only. If  $t_{RCD}$  was greater than the specified  $t_{RCD}$  (MAX) limit, then access time was controlled exclusively by  $t_{CAC}$  ( $t_{RAC}$  [MIN] no longer applied). With or without the  $t_{RCD}$  limit,  $t_{AA}$  and  $t_{CAC}$  must always be met.
16. Either  $t_{RCH}$  or  $t_{RRH}$  must be satisfied for a READ cycle.

17.  $t_{OFF}$  (MAX) defines the time at which the output achieves the open circuit condition and is not referenced to  $V_{OH}$  or  $V_{OL}$ .
18.  $t_{WCS}$ ,  $t_{RWD}$ ,  $t_{AWD}$ , and  $t_{CWD}$  are not restrictive operating parameters.  $t_{WCS}$  applies to EARLY WRITE cycles. If  $t_{WCS} > t_{WCS}$  MIN, the cycle is an EARLY WRITE cycle and the data output will remain an open circuit throughout the entire cycle.  $t_{RWD}$ ,  $t_{AWD}$  and  $t_{CWD}$  define READ-MODIFY-WRITE cycles. Meeting these limits allows for reading and disabling output data and then applying input data. OE# held HIGH and WE# taken LOW after CAS# goes LOW results in a LATE WRITE (OE#-controlled) cycle.  $t_{WCS}$ ,  $t_{RWD}$ ,  $t_{CWD}$  and  $t_{AWD}$  are not applicable in a LATE WRITE cycle.
19. These parameters are referenced to CAS# leading edge in EARLY WRITE cycles and WE# leading edge in LATE WRITE or READ-MODIFY-WRITE cycles.
20. If OE# is tied permanently LOW, LATE WRITE or READ-MODIFY-WRITE operations are not possible.
21. A HIDDEN REFRESH may also be performed after a WRITE cycle. In this case, WE# is LOW and OE# is HIGH.
22. RAS#-ONLY REFRESH requires that all rows be refreshed at least once every 64ms (4,096 rows for the C2 version and 8,192 rows for the P4 version). CBR REFRESH requires that at least 4,096 cycles be completed every 64ms.
23. The DQs open during READ cycles once  $t_{OD}$  or  $t_{OFF}$  occur. If CAS# stays LOW while OE# is brought HIGH, the DQs will open. If OE# is brought back LOW (CAS# still LOW), the DQs will provide the previously read data.
24. LATE WRITE and READ-MODIFY-WRITE cycles must have both  $t_{OD}$  and  $t_{OEH}$  met (OE# HIGH during WRITE cycle) in order to ensure that the output buffers will be open during the WRITE cycle. If OE# is taken back LOW while CAS# remains LOW, the DQs will remain open.
25. Column address changed once each cycle.
26.  $V_{IH}$  overshoot:  $V_{IH}$  (MAX) =  $V_{CC} + 2V$  for a pulse width  $\leq 10ns$ , and the pulse width cannot be greater than one third of the cycle rate.  $V_{IL}$  undershoot:  $V_{IL}$  (MIN) = -2V for a pulse width  $\leq 10ns$ , and the pulse width cannot be greater than one third of the cycle rate.
27. NC pins are assumed to be left floating and are not tested for leakage.



## READ CYCLE



## TIMING PARAMETERS

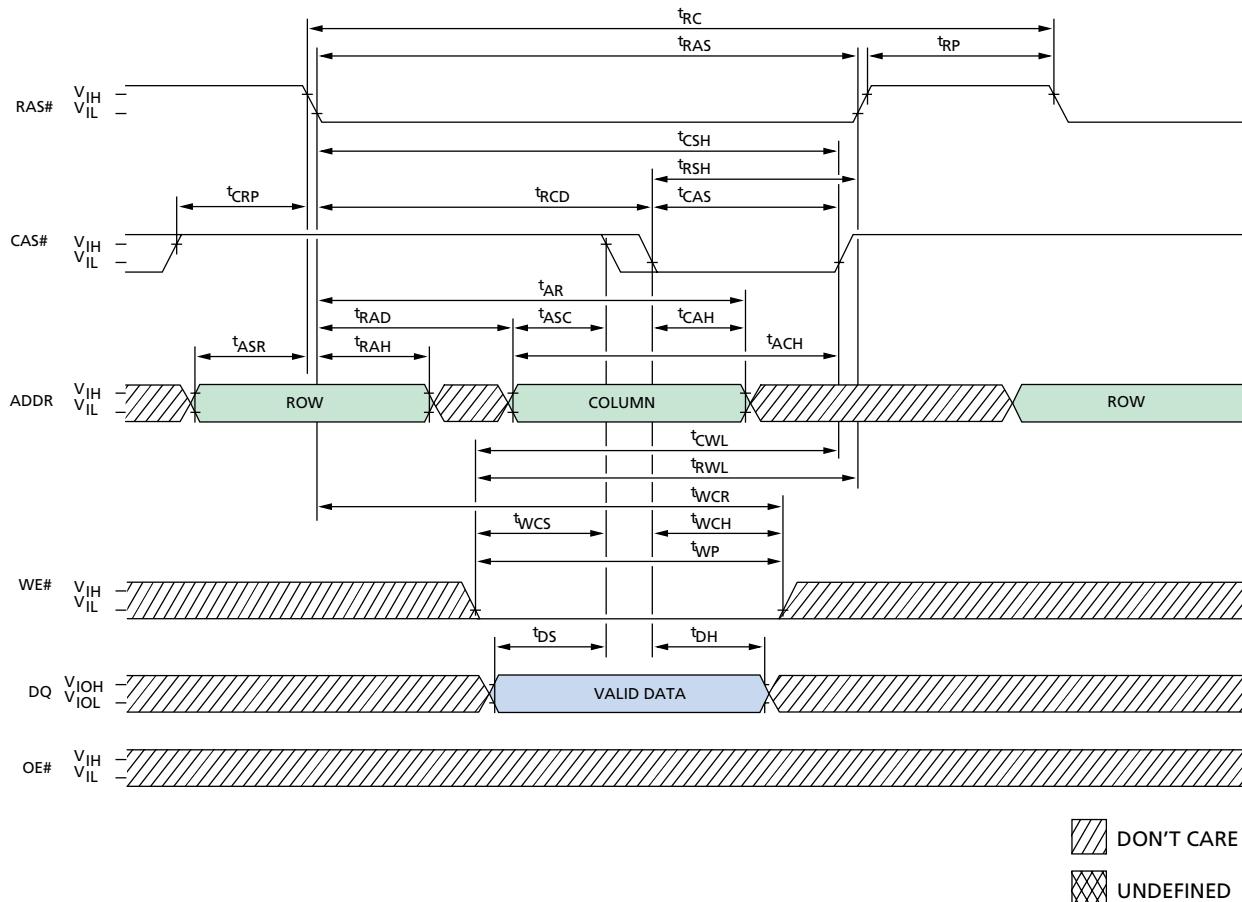
SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>AA</sub>		25		30	ns
t <sub>ACH</sub>	12		15		ns
t <sub>AR</sub>	38		45		ns
t <sub>ASC</sub>	0		0		ns
t <sub>ASR</sub>	0		0		ns
t <sub>CAC</sub>		13		15	ns
t <sub>CAH</sub>	8		10		ns
t <sub>CAS</sub>	8	10,000	10	10,000	ns
t <sub>CLZ</sub>	0		0		ns
t <sub>CRP</sub>	5		5		ns
t <sub>CSH</sub>	38		45		ns
t <sub>OD</sub>	0	12	0	15	ns
t <sub>OE</sub>		12		15	ns

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>OFF</sub>	0	12	0	15	ns
t <sub>RAC</sub>			50		ns
t <sub>RAD</sub>	9		12		ns
t <sub>RAH</sub>	9		10		ns
t <sub>RAS</sub>	50	10,000	60	10,000	ns
t <sub>RC</sub>	84		104		ns
t <sub>RCD</sub>	11		14		ns
t <sub>RCH</sub>	0		0		ns
t <sub>RCS</sub>	0		0		ns
t <sub>RP</sub>	30		40		ns
t <sub>RRH</sub>	0		0		ns
t <sub>RSH</sub>	13		15		ns

**NOTE:** 1. t<sub>OFF</sub> is referenced from rising edge of RAS# or CAS#, whichever occurs last.



## EARLY WRITE CYCLE



## TIMING PARAMETERS

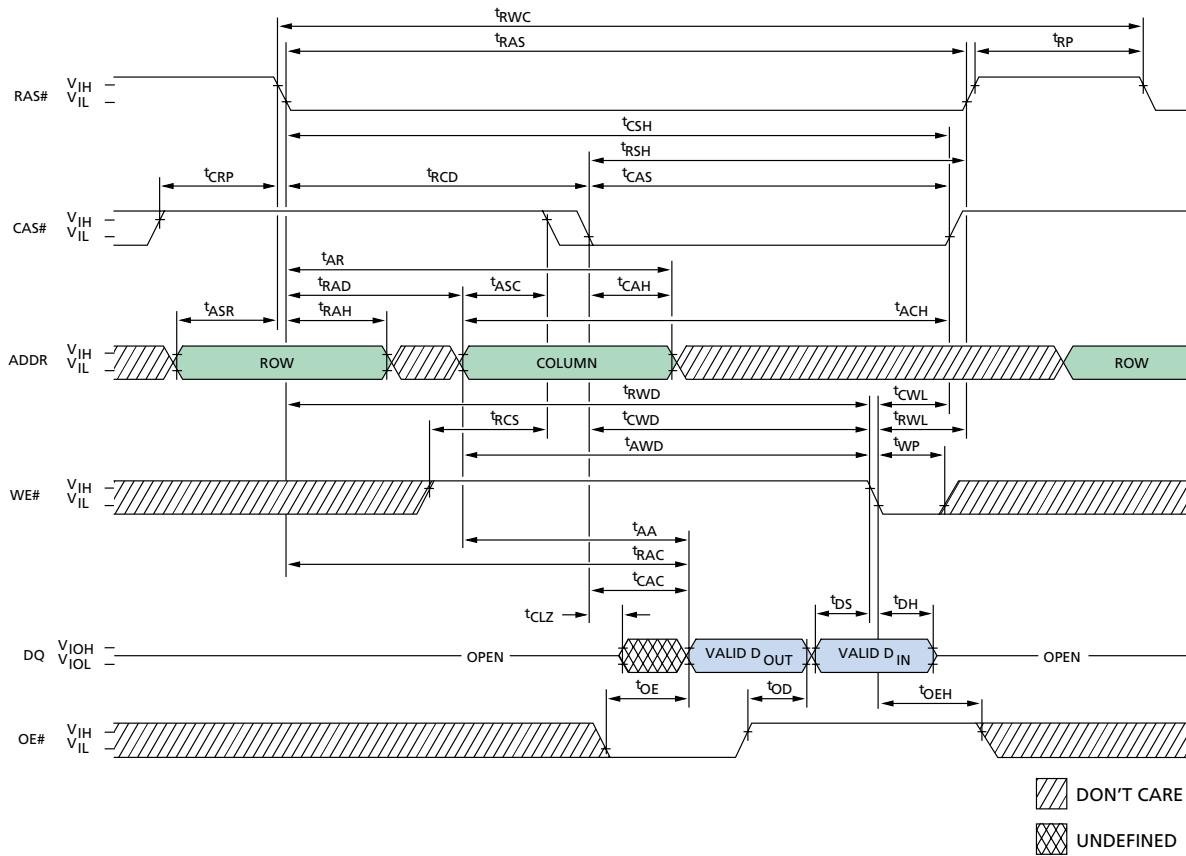
SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
$t_{ACH}$	12		15		ns
$t_{AR}$	38		45		ns
$t_{ASC}$	0		0		ns
$t_{ASR}$	0		0		ns
$t_{CAH}$	8		10		ns
$t_{CAS}$	8	10,000	10	10,000	ns
$t_{CRP}$	5		5		ns
$t_{CSH}$	38		45		ns
$t_{CWL}$	8		15		ns
$t_{DH}$	8		10		ns
$t_{DS}$	0		0		ns
$t_{RAD}$	9		12		ns

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
$t_{RAH}$	9		10		ns
$t_{RAS}$	50	10,000	60	10,000	ns
$t_{RC}$	84		104		ns
$t_{RCD}$	11		14		ns
$t_{RP}$	30		40		ns
$t_{RSH}$	13		15		ns
$t_{RWL}$	13		15		ns
$t_{WCH}$	8		10		ns
$t_{WCR}$	38		45		ns
$t_{WCS}$	0		0		ns
$t_{WP}$	5		5		ns



## READ WRITE CYCLE

(LATE WRITE and READ-MODIFY-WRITE cycles)



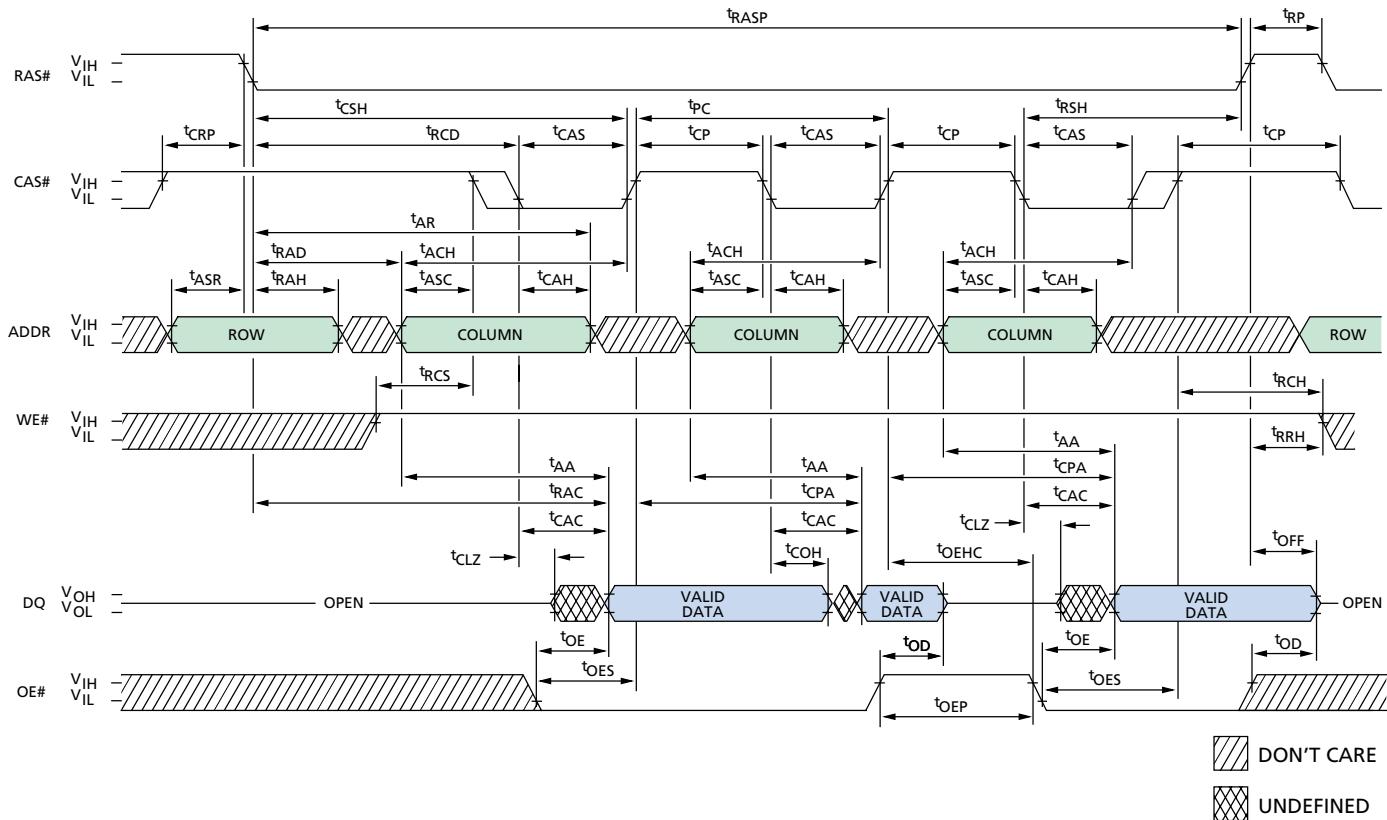
### TIMING PARAMETERS

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>AA</sub>		25		30	ns
t <sub>ACH</sub>	12		15		ns
t <sub>AR</sub>	38		45		ns
t <sub>ASC</sub>	0		0		ns
t <sub>ASR</sub>	0		0		ns
t <sub>AWD</sub>	42		49		ns
t <sub>CAC</sub>		13		15	ns
t <sub>CAH</sub>	8		10		ns
t <sub>CAS</sub>	8	10,000	10	10,000	ns
t <sub>CLZ</sub>	0		0		ns
t <sub>CRP</sub>	5		5		ns
t <sub>CSH</sub>	38		45		ns
t <sub>CWD</sub>	28		35		ns
t <sub>CWL</sub>	8		10		ns
t <sub>DH</sub>	8		10		ns
t <sub>DS</sub>	0		0		ns

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>OD</sub>	0	12	0	15	ns
t <sub>OE</sub>		12		15	ns
t <sub>OEH</sub>	8		10		ns
t <sub>RAC</sub>		50		60	ns
t <sub>RAD</sub>	9		12		ns
t <sub>RAH</sub>	9		10		ns
t <sub>RAS</sub>	50	10,000	60	10,000	ns
t <sub>RCD</sub>	11		14		ns
t <sub>RCS</sub>	0		0		ns
t <sub>RP</sub>	30		40		ns
t <sub>RSH</sub>	13		15		ns
t <sub>RWC</sub>	116		140		ns
t <sub>RWD</sub>	67		79		ns
t <sub>RVWL</sub>	13		15		ns
t <sub>WP</sub>	5		5		ns



## EDO-PAGE-MODE READ CYCLE



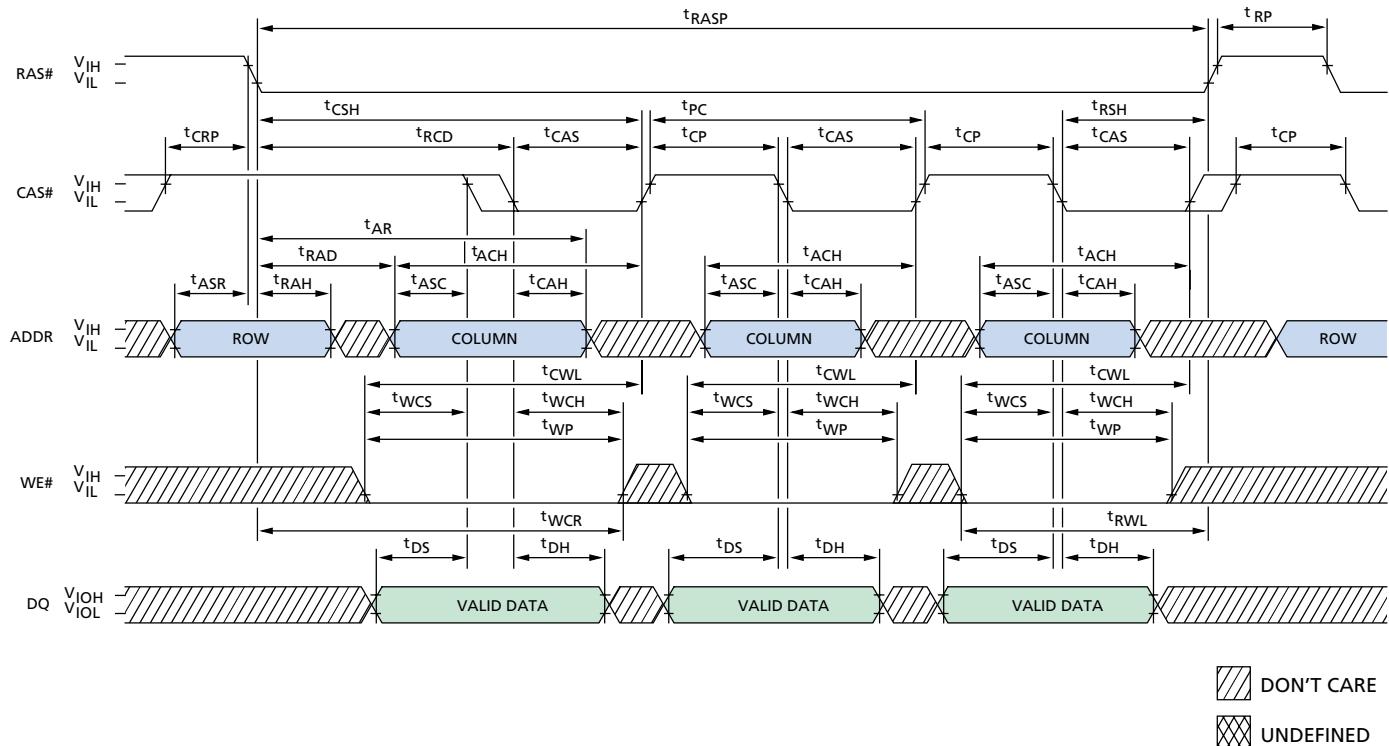
## TIMING PARAMETERS

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>AA</sub>		25		30	ns
t <sub>ACH</sub>	12		15		ns
t <sub>AR</sub>	38		45		ns
t <sub>ASC</sub>	0		0		ns
t <sub>ASR</sub>	0		0		ns
t <sub>CAC</sub>		13		15	ns
t <sub>CAH</sub>	8		10		ns
t <sub>CAS</sub>	8	10,000	10	10,000	ns
t <sub>CLZ</sub>	0		0		ns
t <sub>COH</sub>	3		3		ns
t <sub>CP</sub>	8		10		ns
t <sub>CPA</sub>		28		35	ns
t <sub>CRP</sub>	5		5		ns
t <sub>CSH</sub>	38		45		ns
t <sub>OD</sub>	0	12	0	15	ns
t <sub>OE</sub>		12		15	ns

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>OEHC</sub>	5		10		ns
t <sub>OEP</sub>	5		5		ns
t <sub>OES</sub>	4		5		ns
t <sub>OFF</sub>	0	12	0	15	ns
t <sub>PC</sub>	20		25		ns
t <sub>RAC</sub>		50		60	ns
t <sub>RAD</sub>	9		12		ns
t <sub>RAH</sub>	9		10		ns
t <sub>RASP</sub>	50	125,000	60	125,000	ns
t <sub>RCD</sub>	11		14		ns
t <sub>RCH</sub>	0		0		ns
t <sub>RCS</sub>	0		0		ns
t <sub>RP</sub>	30		40		ns
t <sub>RRH</sub>	0		0		ns
t <sub>RSH</sub>	13		15		ns



## EDO-PAGE-MODE EARLY WRITE CYCLE



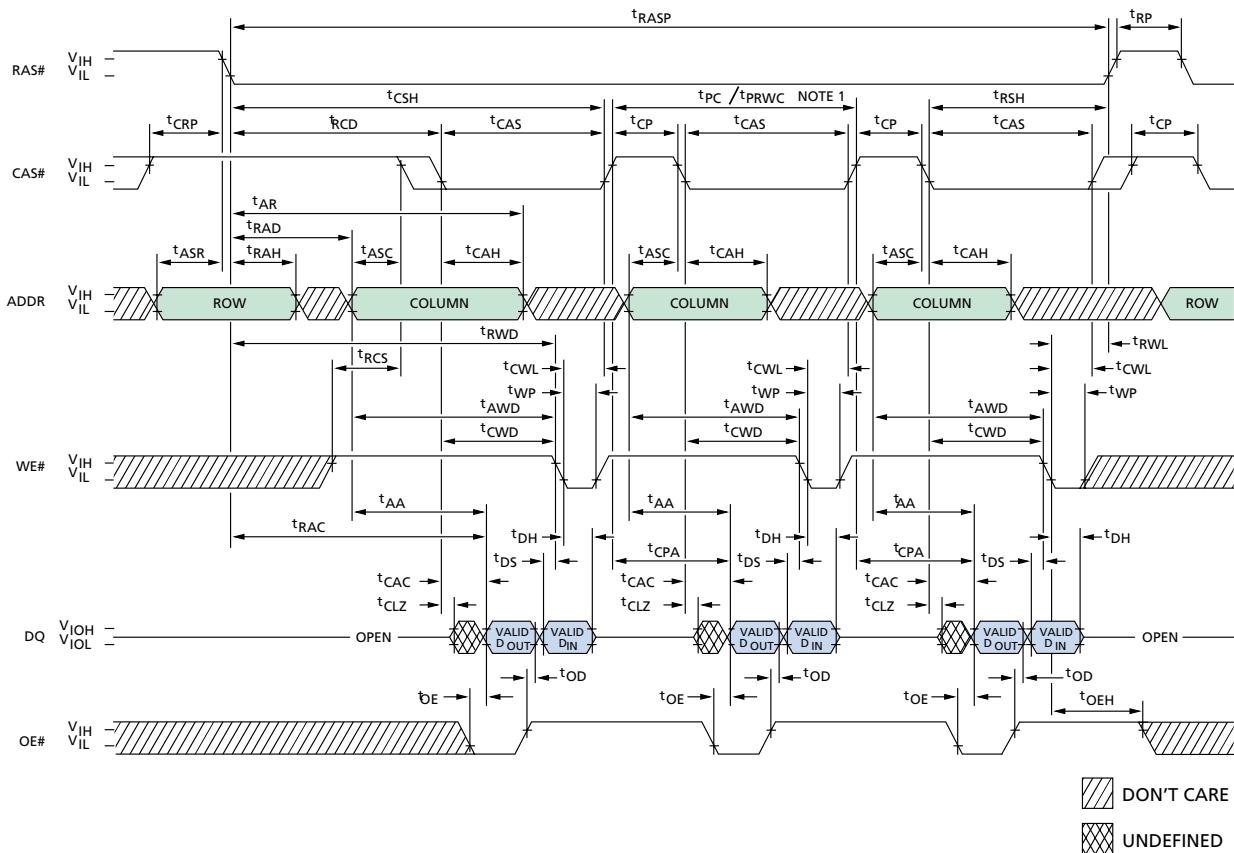
## TIMING PARAMETERS

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>ACH</sub>	12		15		ns
t <sub>AR</sub>	38		45		ns
t <sub>ASC</sub>	0		0		ns
t <sub>ASR</sub>	0		0		ns
t <sub>CAH</sub>	8		10		ns
t <sub>CAS</sub>	8	10,000	10	10,000	ns
t <sub>CP</sub>	8		10		ns
t <sub>CRP</sub>	5		5		ns
t <sub>CSH</sub>	38		45		ns
t <sub>CWL</sub>	8		10		ns
t <sub>DH</sub>	8		10		ns
t <sub>DS</sub>	0		0		ns

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>PC</sub>	20		25		ns
t <sub>RAD</sub>	9		12		ns
t <sub>RAH</sub>	9		10		ns
t <sub>RASP</sub>	50	125,000	60	125,000	ns
t <sub>RCD</sub>	11		14		ns
t <sub>RP</sub>	30		40		ns
t <sub>RSH</sub>	13		15		ns
t <sub>RWL</sub>	13		15		ns
t <sub>WCH</sub>	8		10		ns
t <sub>WCR</sub>	38		45		ns
t <sub>WCS</sub>	0		0		ns
t <sub>WP</sub>	5		5		ns



## EDO-PAGE-MODE READ-WRITE CYCLE (LATE WRITE and READ-MODIFY-WRITE cycles)



DON'T CARE  
 UNDEFINED

### TIMING PARAMETERS

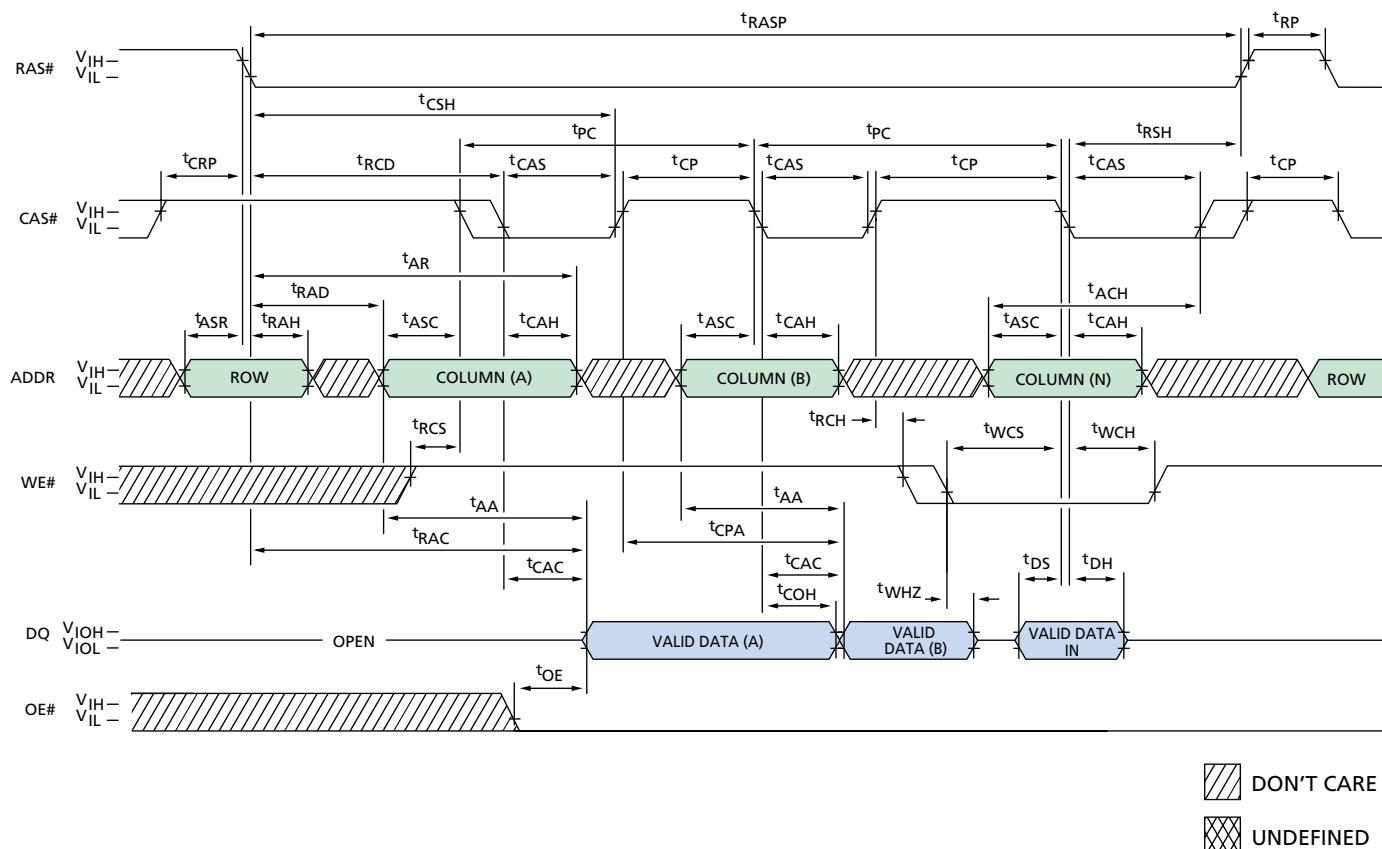
SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>AA</sub>		25		30	ns
t <sub>AR</sub>	38		45		ns
t <sub>ASC</sub>	0		0		ns
t <sub>ASR</sub>	0		0		ns
t <sub>AWD</sub>	42		49		ns
t <sub>CAC</sub>		13		15	ns
t <sub>CAH</sub>	8		10		ns
t <sub>CAS</sub>	8	10,000	10	10,000	ns
t <sub>CLZ</sub>	0		0		ns
t <sub>CP</sub>	8		10		ns
t <sub>CPA</sub>		28		35	ns
t <sub>CRP</sub>	5		5		ns
t <sub>CSH</sub>	38		45		ns
t <sub>CWD</sub>	28		35		ns
t <sub>CWL</sub>	8		10		ns
t <sub>DH</sub>	8		10		ns
t <sub>DS</sub>	0		0		ns

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>OD</sub>	0	12	0	15	ns
t <sub>OE</sub>		12		15	ns
t <sub>OEH</sub>	8		12		ns
t <sub>PC</sub>	20		25		ns
t <sub>PRWC</sub>	47		56		ns
t <sub>RAC</sub>		50		60	ns
t <sub>RAD</sub>	9		12		ns
t <sub>RAH</sub>	9		10		ns
t <sub>RASP</sub>	50	125,000	60	125,000	ns
t <sub>RCD</sub>	11		14		ns
t <sub>RCS</sub>	0		0		ns
t <sub>RP</sub>	30		40		ns
t <sub>RSH</sub>	13		15		ns
t <sub>RWD</sub>	67		79		ns
t <sub>RWL</sub>	13		15		ns
t <sub>WP</sub>	5		5		ns

**NOTE:** 1. t<sub>PC</sub> is for LATE WRITE cycles only.



## EDO-PAGE-MODE READ EARLY WRITE CYCLE (Pseudo READ-MODIFY-WRITE)



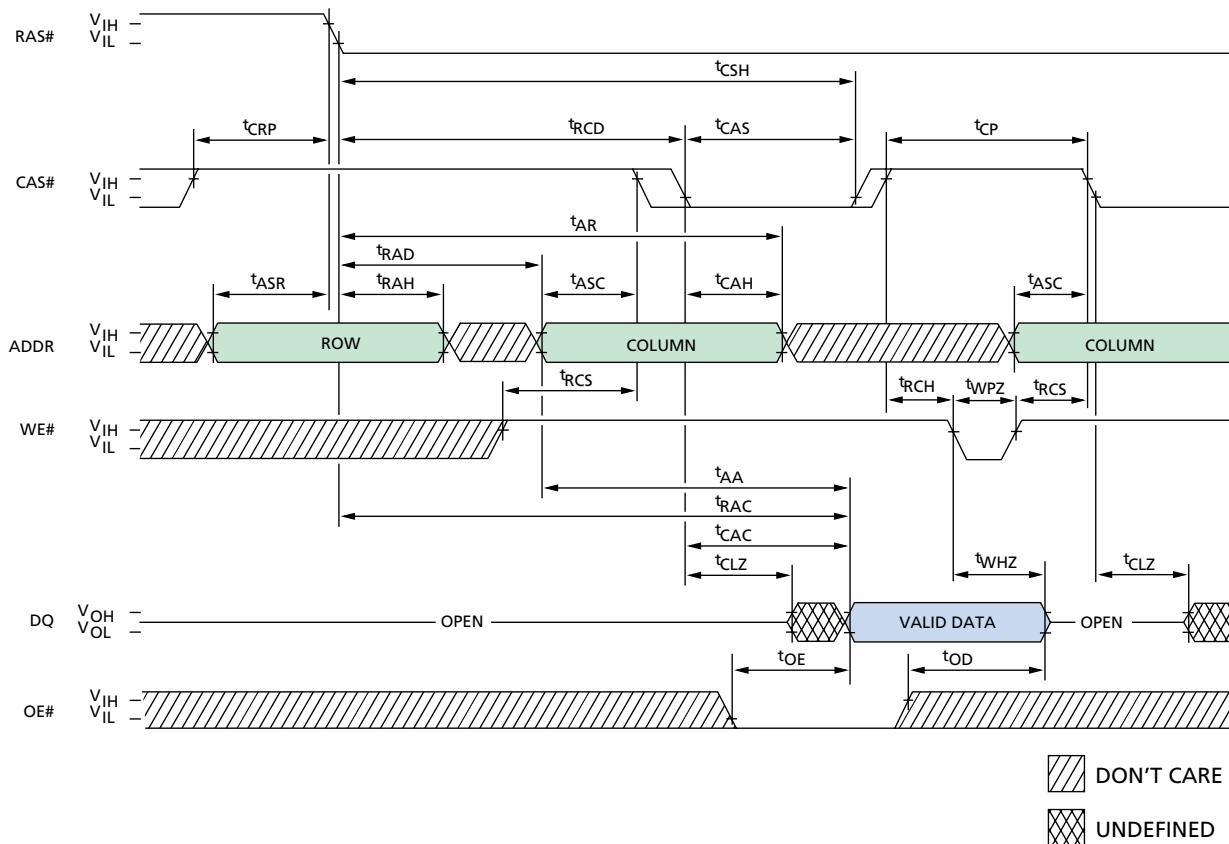
### TIMING PARAMETERS

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>AA</sub>		25		30	ns
t <sub>ACH</sub>	12		15		ns
t <sub>AR</sub>	38		45		ns
t <sub>ASC</sub>	0		0		ns
t <sub>ASR</sub>	0		0		ns
t <sub>CAC</sub>		13		15	ns
t <sub>CAH</sub>	8		10		ns
t <sub>CAS</sub>	8	10,000	10	10,000	ns
t <sub>COH</sub>	3		3		ns
t <sub>CP</sub>	8		10		ns
t <sub>CPA</sub>		28		35	ns
t <sub>CRP</sub>	5		5		ns
t <sub>CSH</sub>	38		45		ns
t <sub>DH</sub>	8		10		ns
t <sub>DS</sub>	0		0		ns

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>OE</sub>		12		15	ns
t <sub>PC</sub>	20		25		ns
t <sub>RAC</sub>		50		60	ns
t <sub>RAD</sub>	9		12		ns
t <sub>RAH</sub>	9		10		ns
t <sub>RASP</sub>	50	125,000	60	125,000	ns
t <sub>RCD</sub>	11		14		ns
t <sub>RCH</sub>	0		0		ns
t <sub>RCS</sub>	0		0		ns
t <sub>RP</sub>	30		40		ns
t <sub>RSH</sub>	13		15		ns
t <sub>WCH</sub>	8		10		ns
t <sub>WCS</sub>	0		0		ns
t <sub>WHZ</sub>	0	12	0	15	ns



## READ CYCLE (with WE#-controlled disable)



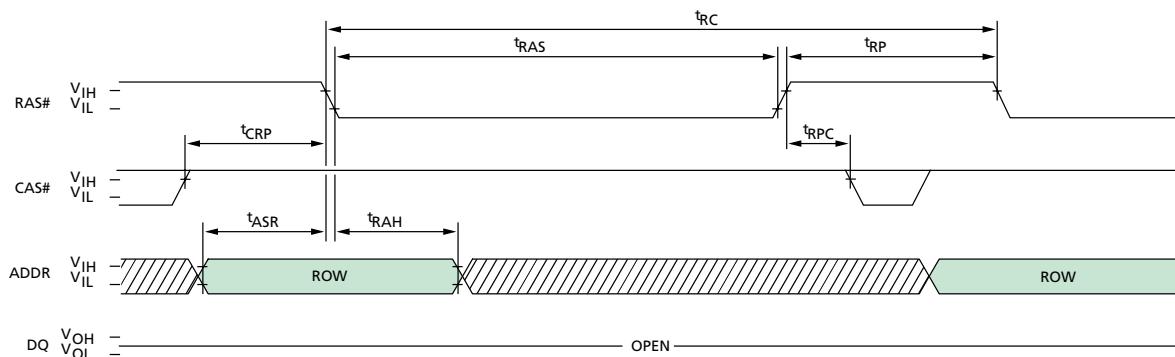
### TIMING PARAMETERS

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>AA</sub>		25		30	ns
t <sub>AR</sub>	38		45		ns
t <sub>ASC</sub>	0		0		ns
t <sub>ASR</sub>	0		0		ns
t <sub>CAC</sub>		13		15	ns
t <sub>CAH</sub>	8		10		ns
t <sub>CAS</sub>	8	10,000	10	10,000	ns
t <sub>CLZ</sub>	0		0		ns
t <sub>CP</sub>	8		10		ns
t <sub>CRP</sub>	5		5		ns
t <sub>CSH</sub>	38		45		ns

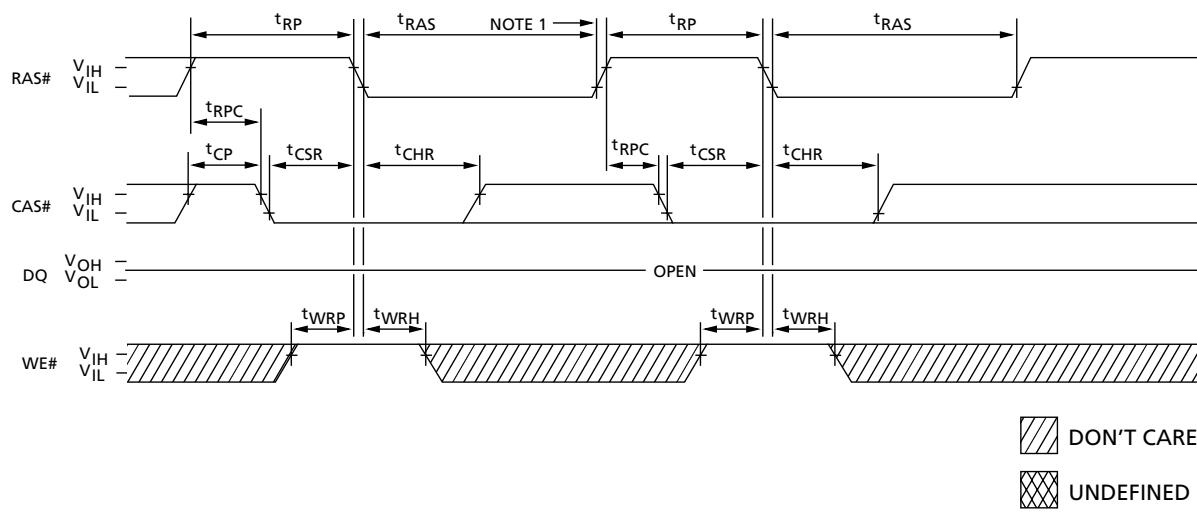
SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>OD</sub>	0	12	0	15	ns
t <sub>OE</sub>		12		15	ns
t <sub>RAC</sub>		50		60	ns
t <sub>RAD</sub>	9		12		ns
t <sub>RAH</sub>	9		10		ns
t <sub>RCD</sub>	11		14		ns
t <sub>RCH</sub>	0		0		ns
t <sub>RCS</sub>	0		0		ns
t <sub>WHZ</sub>		12		15	ns
t <sub>WPZ</sub>	10		10		ns



### RAS#-ONLY REFRESH CYCLE (OE# and WE# = DON'T CARE)



### CBR REFRESH CYCLE (Addresses and OE# = DON'T CARE)



### TIMING PARAMETERS

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>ASR</sub>	0		0		ns
t <sub>CHR</sub>	8		10		ns
t <sub>CP</sub>	8		10		ns
t <sub>CRP</sub>	5		5		ns
t <sub>CSR</sub>	5		5		ns
t <sub>RAH</sub>	9		10		ns

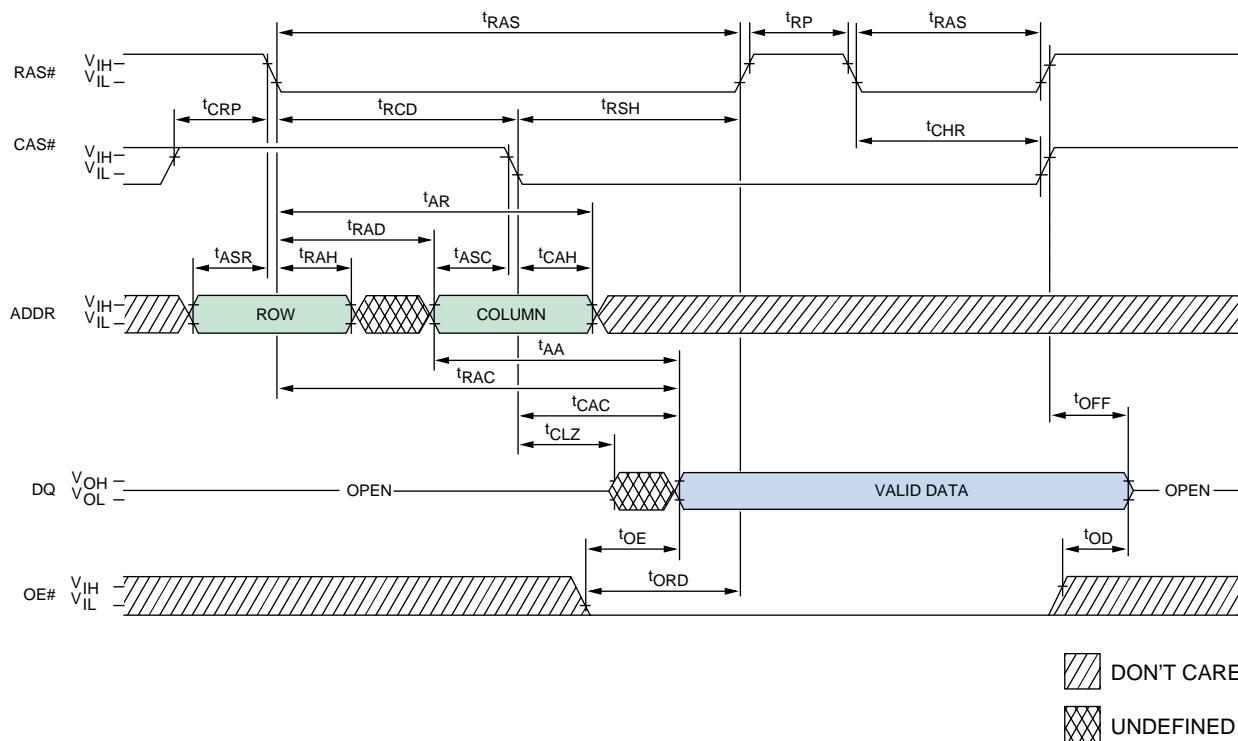
SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>RAS</sub>	50	10,000	60	10,000	ns
t <sub>RC</sub>	84		104		ns
t <sub>RP</sub>	30		40		ns
t <sub>RPC</sub>	5		5		ns
t <sub>WRH</sub>	8		10		ns
t <sub>WRP</sub>	8		10		ns

**NOTE:** 1. End of first CBR REFRESH cycle.



## HIDDEN REFRESH CYCLE 1

(WE# = HIGH; OE# = LOW)



### TIMING PARAMETERS

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>AA</sub>		25		30	ns
t <sub>AR</sub>	38		45		ns
t <sub>ASC</sub>	0		0		ns
t <sub>ASR</sub>	0		0		ns
t <sub>CAC</sub>		13		15	ns
t <sub>CAH</sub>	8		10		ns
t <sub>CHR</sub>	8		10		ns
t <sub>CLZ</sub>	0		0		ns
t <sub>CRP</sub>	5		5		ns
t <sub>OD</sub>	0	12	0	15	ns

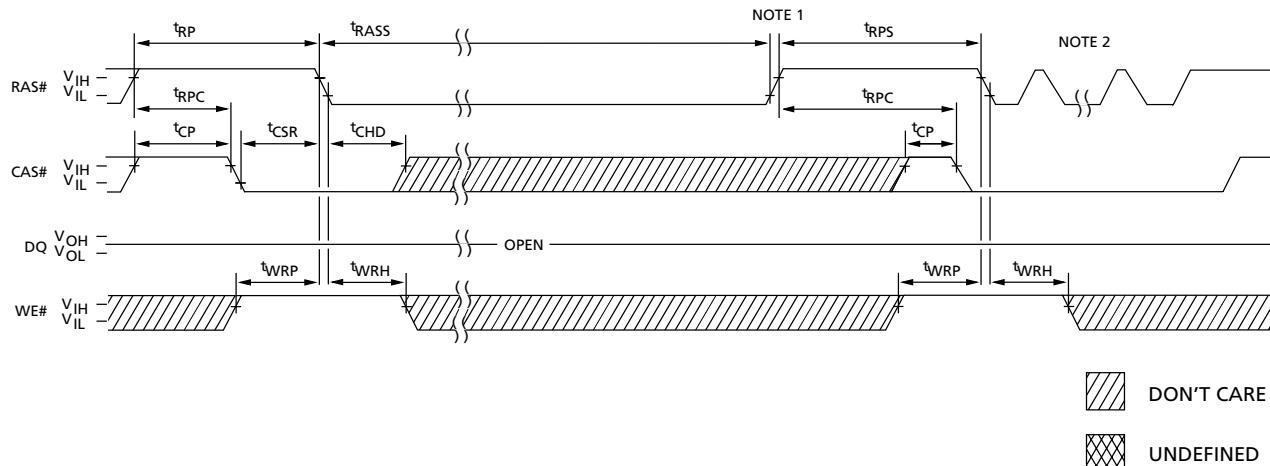
SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
t <sub>OE</sub>		12		15	ns
t <sub>OFF</sub>	0	12	0	15	ns
t <sub>ORD</sub>	0		0		ns
t <sub>RAC</sub>		50		60	ns
t <sub>RAD</sub>	9		12		ns
t <sub>RAH</sub>	9		10		ns
t <sub>RAS</sub>	50	10,000	60	10,000	ns
t <sub>RCD</sub>	11		14		ns
t <sub>RP</sub>	30		40		ns
t <sub>RSH</sub>	13		15		ns

**NOTE:** 1. A HIDDEN REFRESH may also be performed after a WRITE cycle. In this case, WE# is LOW and OE# is HIGH.



## SELF REFRESH CYCLE

(Addresses and OE# = DON'T CARE)



### TIMING PARAMETERS

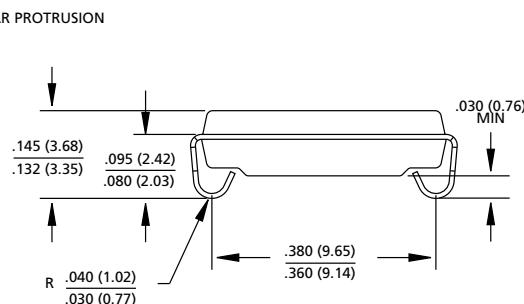
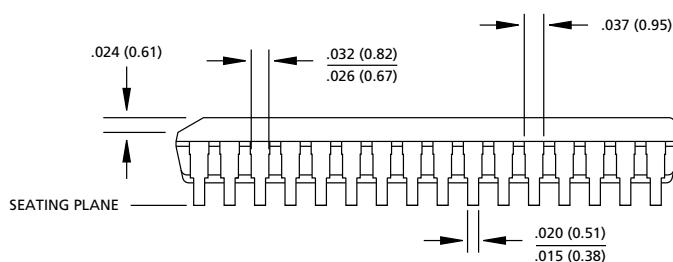
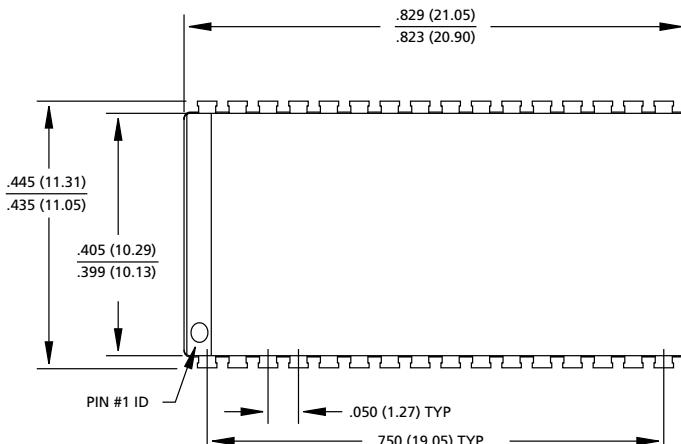
SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
$t_{CHD}$	15		15		ns
$t_{CP}$	8		10		ns
$t_{CSR}$	5		5		ns
$t_{RASS}$	100		100		$\mu s$
$t_{RP}$	30		40		ns

SYMBOL	-5		-6		UNITS
	MIN	MAX	MIN	MAX	
$t_{RPC}$	5		5		ns
$t_{RPS}$	90		105		ns
$t_{WRH}$	8		10		ns
$t_{WRP}$	8		10		ns

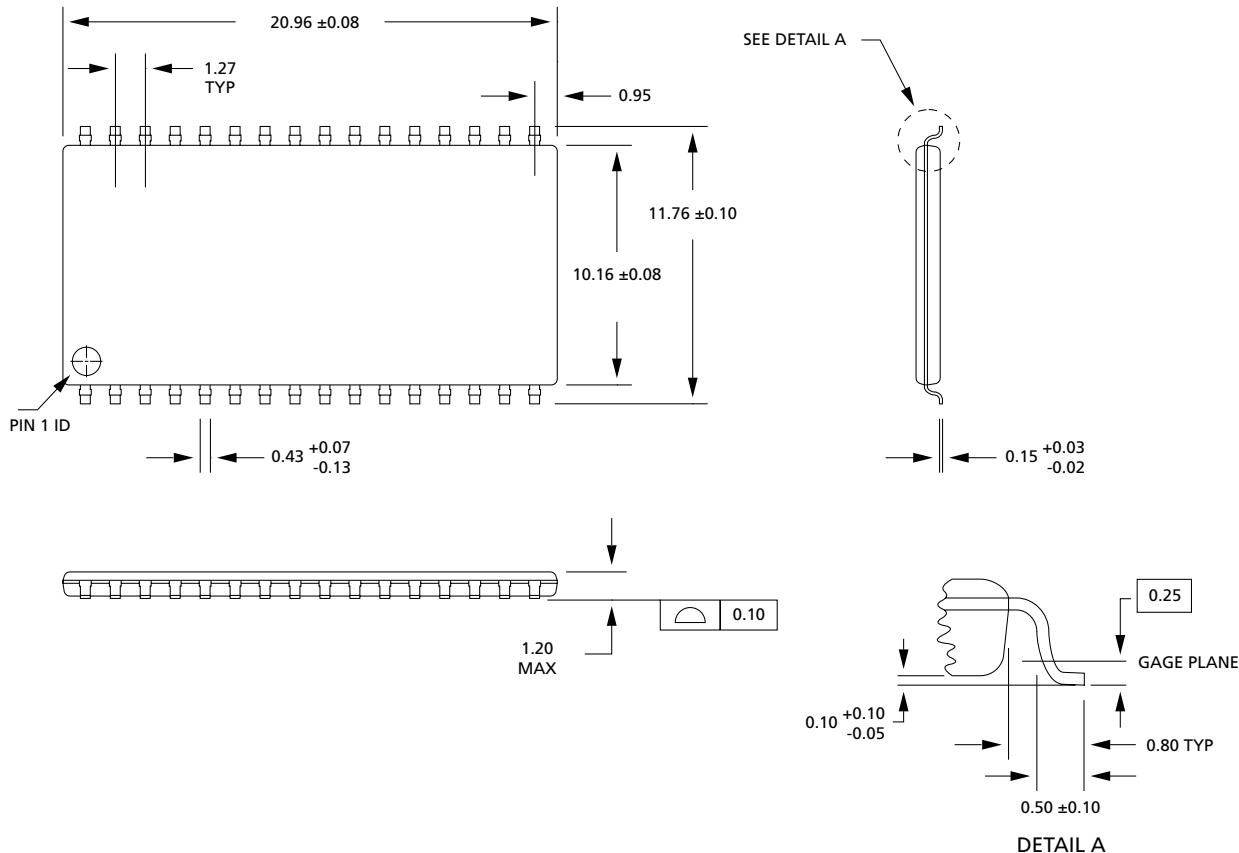
**NOTE:** 1. Once  $t_{RASS}$  (MIN) is met and RAS# remains LOW, the DRAM will enter self refresh mode.  
 2. Once  $t_{RPS}$  is satisfied, a complete burst of all rows should be executed if RAS#-only or burst CBR refresh



## 32-PIN PLASTIC SOJ (400 mil)



**NOTE:** 1. All dimensions in inches (millimeters) **MAX** or typical where noted.  
**MIN**  
 2. Package width and length do not include mold protrusion; allowable mold protrusion is .01" per side.

**32-PIN PLASTIC TSOP (400 mil)**


- NOTE:**
1. All dimensions in millimeters **MAX** or typical where noted.  
**MIN**
  2. Package width and length do not include mold protrusion; allowable mold protrusion is .25mm per side.



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